

CoolMOS® Power Transistor

Features

- Lowest figure-of-merit $R_{\text{ON}} x Q_{\text{g}}$
- Ultra low gate charge
- Extreme dv/dt rated
- · High peak current capability
- Qualified for industrial grade applications according to JEDEC¹⁾
- · Pb-free lead plating; RoHS compliant

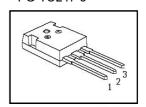
CoolMOS CP is specially designed for:

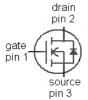
• Hard switching topologies, for Server and Telecom

Product Summary

V _{DS} @ T _{j,max}	650	٧
R _{DS(on),max}	0.165	Ω
Q _{g,typ}	39	nC







Туре	Package	Ordering Code	Marking
IPW60R165CP	PG-TO247-3	SP000095483	6R165P

Maximum ratings, at T_i=25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I _D	T _C =25 °C	21	A
		T _C =100 °C	13	
Pulsed drain current ²⁾	/ _{D,pulse}	T _C =25 °C	61	
Avalanche energy, single pulse	EAS	I _D =7.9 A, V _{DD} =50 V	522	mJ
Avalanche energy, repetitive $t_{\rm AR}^{-2),3)}$	E _{AR}	I _D =7.9 A, V _{DD} =50 V	0.79	
Avalanche current, repetitive $t_{AR}^{2),3)}$	/ _{AR}		7.9	A
MOSFET dv/dt ruggedness	dv/dt	V _{DS} =0480 V	50	V/ns
Gate source voltage	V _{GS}	static	±20	V
		AC (f>1 Hz)	±30	
Power dissipation	P _{tot}	T _C =25 °C	192	W
Operating and storage temperature	T _j , T _{stg}		-55 150	°C
Mounting torque		M3 and M3.5 screws	60	Ncm



Maximum ratings, at T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous diode forward current	Is	Т _С =25 °С	12	А
Diode pulse current ²⁾	I _{S,pulse}	7 c-23 G	61	
Reverse diode d <i>v I</i> d <i>t</i> ⁴⁾	dv/dt		15	V/ns

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	R _{thJC}		-	-	0.65	K/W
Thermal resistance, junction - ambient	$R_{ m thJA}$	leaded	-	-	62	
Soldering temperature, wavesoldering only allowed at leads	$T_{\rm sold}$	1.6 mm (0.063 in.) from case for 10 s	-	-	260	°C

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =0 V, I _D =250 μA	600	1	1	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 0.79 \text{ mA}$	2.5	3	3.5	
Zero gate voltage drain current	I _{DSS}	V _{DS} =600 V, V _{GS} =0 V, T _j =25 °C	-	-	1	μΑ
		V _{DS} =600 V, V _{GS} =0 V, T _j =150 °C	-	10	-	
Gate-source leakage current	I _{GSS}	V _{GS} =20 V, V _{DS} =0 V	-	-	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =10 V, I _D =12 A, T _j =25 °C	-	0.15	0.165	Ω
		V _{GS} =10 V, I _D =12 A, T _j =150 °C	-	0.40	-	
Gate resistance	R _G	f=1 MHz, open drain	-	1.9	-	Ω



Parameter	Symbol Conditions		Values			Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C iss	V _{GS} =0 V, V _{DS} =100 V,	-	2000	-	pF
Output capacitance	C oss	f=1 MHz	1	100	-	
Effective output capacitance, energy related ⁵⁾	C _{o(er)}	V _{GS} =0 V, V _{DS} =0 V to 480 V	-	83	-	
Effective output capacitance, time related ⁶⁾	C _{o(tr)}		-	220	-	
Turn-on delay time	t _{d(on)}	V _{DD} =400 V, V _{GS} =10V,	-	12	-	ns
Rise time	t _r		-	5	-	
Turn-off delay time	$t_{d(off)}$	$I_{\rm D}$ =12 A, $R_{\rm G}$ =3.3 Ω	-	50	-	
Fall time	t _f		-	5	-	
Gate Charge Characteristics						
Gate to source charge	Q _{gs}		-	9	-	nC
Gate to drain charge	Q_{gd}	V _{DD} =400 V, / _D =12 A,	-	13.0	-	
Gate charge total	Qg	V _{GS} =0 to 10 V	_	39	52	
Gate plateau voltage	V _{plateau}		-	5.0	-	V
Reverse Diode						
Diode forward voltage	V _{SD}	V _{GS} =0 V, I _F =12 A, T _j =25 °C	-	0.9	1.2	V
Reverse recovery time	t _{rr}	V_{R} =400 V, I_{F} = I_{S} , di_{F}/dt =100 A/ μ s	-	390	-	ns
Reverse recovery charge	Qrr		-	7.5	-	μC
Peak reverse recovery current	I _{rrm}		-	38	-	А

¹⁾ J-STD20 and JESD22

²⁾ Pulse width t_p limited by $T_{\rm j,max}$

 $^{^{3)}}$ Repetitive avalanche causes additional power losses that can be calculated as $P_{\rm AV}$ = $E_{\rm AR}$ *f.

 $^{^{4)}} I_{SD} \!\! \leq \!\! I_D, \, di/dt \!\! \leq \!\! 200A/\mu s, \, V_{DClink} \!\! = \!\! 400V, \, V_{peak} \!\! < \!\! V_{(BR)DSS}, \, T_j \!\! < \!\! T_{jmax}, \, identical \, low \, side \, and \, high \, side \, switch \, denoted by the peak of the pe$

 $^{^{5)}}$ $C_{\rm o(er)}$ is a fixed capacitance that gives the same stored energy as $C_{\rm oss}$ while $V_{\rm DS}$ is rising from 0 to 80% $V_{\rm DSS}$.

 $^{^{6)}}$ C $_{\mathrm{o(tr)}}$ is a fixed capacitance that gives the same charging time as C $_{\mathrm{oss}}$ while V_{DS} is rising from 0 to 80% V_{DSS} .



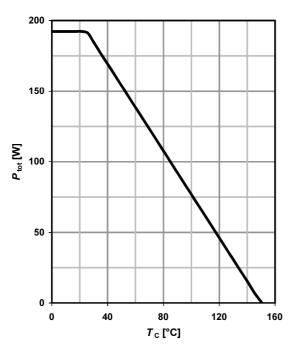
1 Power dissipation

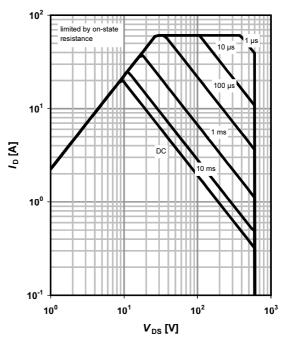
P_{tot} =f(T_{C})

2 Safe operating area

 I_D =f(V_{DS}); T_C =25 °C; D=0

parameter: t_p





3 Max. transient thermal impedance

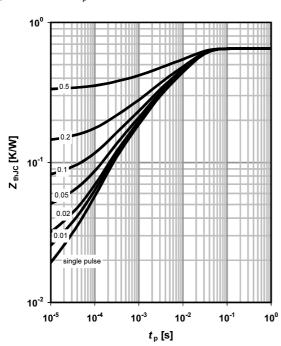
 Z_{thJC} = $f(t_P)$

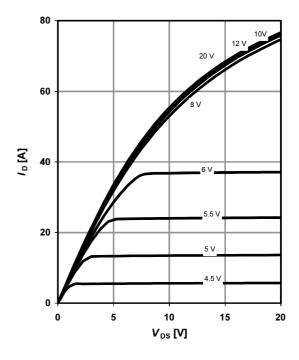
parameter: D=t_p/T

4 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 \text{ °C}$

parameter: V_{GS}



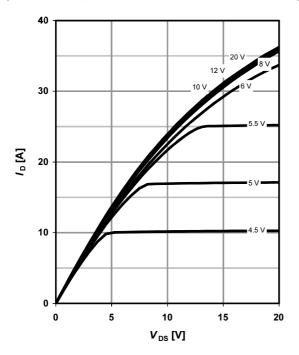




5 Typ. output characteristics

 $I_{D} = f(V_{DS}); T_{j} = 150 \text{ °C}$

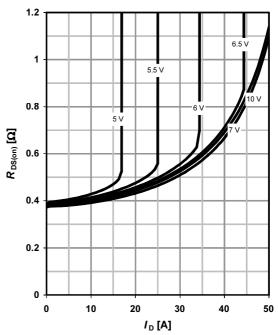
parameter: V_{GS}



6 Typ. drain-source on-state resistance

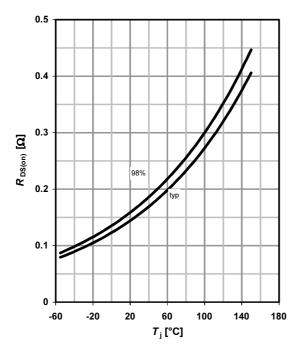
 $R_{DS(on)}$ =f(I_D); T_j =150 °C

parameter: V_{GS}



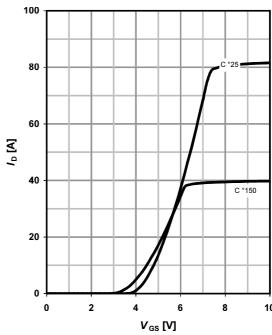
7 Drain-source on-state resistance

 $R_{DS(on)} = f(T_i); I_D = 12 \text{ A}; V_{GS} = 10 \text{ V}$



8 Typ. transfer characteristics

 $I_{\rm D}$ =f($V_{\rm GS}$); $|V_{\rm DS}|$ >2 $|I_{\rm D}|R_{\rm DS(on)max}$ parameter: $T_{\rm j}$



140

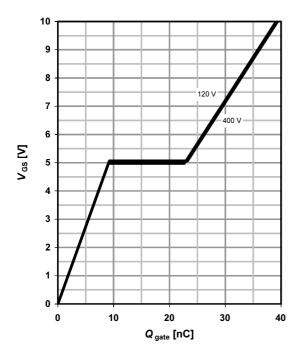
180



9 Typ. gate charge

 V_{GS} =f(Q_{gate}); I_D =12 A pulsed

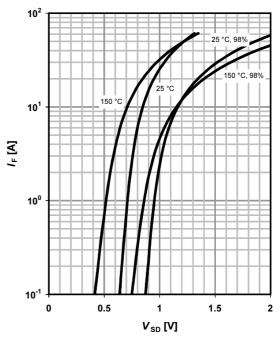
parameter: $V_{\rm DD}$



10 Forward characteristics of reverse diode

 $I_F = f(V_{SD})$

parameter: T_j

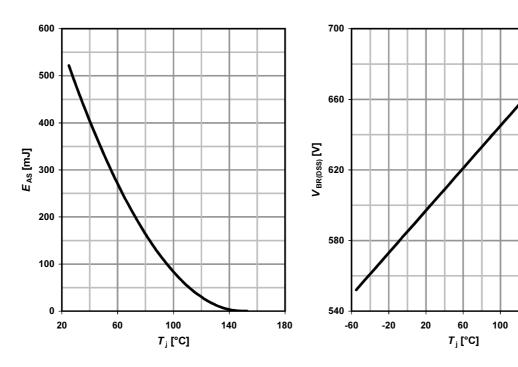


11 Avalanche energy

 $E_{AS} = f(T_i); I_D = 7.9 \text{ A}; V_{DD} = 50 \text{ V}$

12 Drain-source breakdown voltage

 $V_{BR(DSS)}$ =f(T_i); I_D =0.25 mA



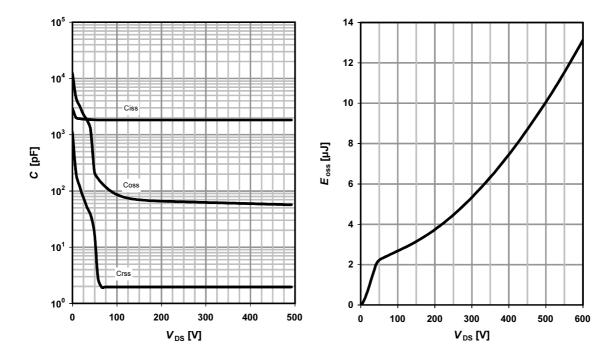


13 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$

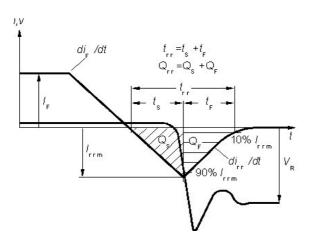
14 Typ. Coss stored energy

$$E_{oss} = f(V_{DS})$$



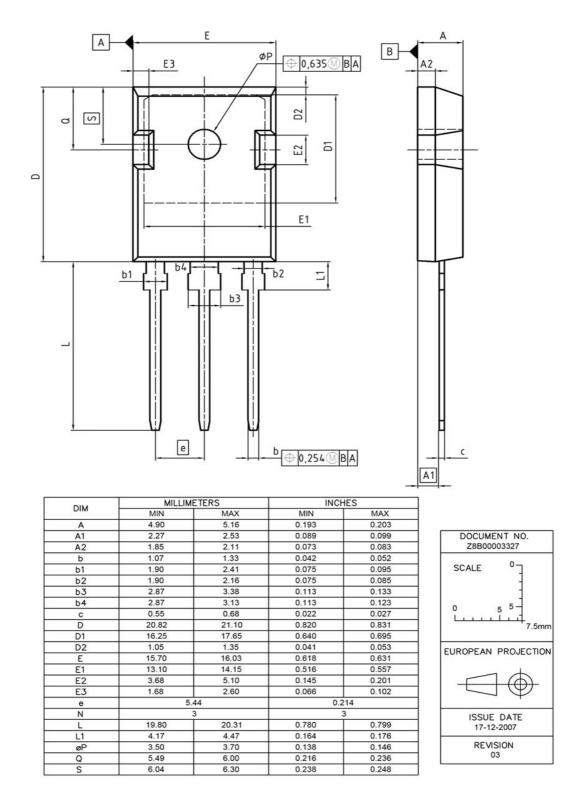


Definition of diode switching characteristics





PG-TO247-3: Outline





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Infineon Technologies AG
81726 Munich, Germany
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New package outlines TO-247

1 New package outlines TO-247

Assembly capacity extension for CoolMOSTM technology products assembled in lead-free package PG-TO247-3 at subcontractor ASE (Weihai) Inc., China (Changes are marked in blue.)

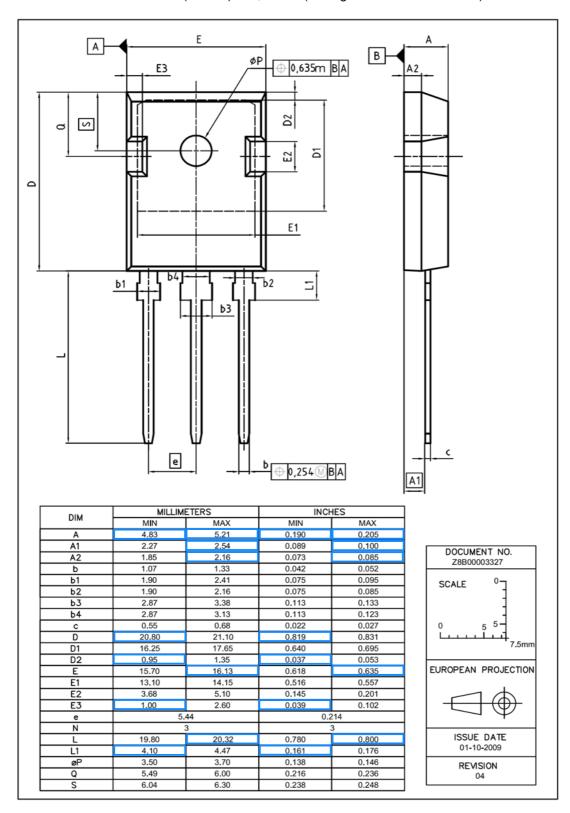


Figure 1 Outlines TO-247, dimensions in mm/inches

Final Data Sheet Erratum Rev. 2.0, 2010-02-01